MIL-D-28000

Test Case

Index and Abstracts

19 March 1993

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Prepared for
Electronic Systems Center

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1. Introduction

This guide provides abstracts of test cases developed according to reference [1], Test Case Development and Verification Guide for MIL-D-28000, for use in testing according to reference [2], Test Plan to Evaluate Computer-Aided Design Systems for MIL-D-28000 Compliance With Additional User Requirements. Reference [2] presents the procedures on testing Initial Graphics Exchange Specification (IGES) processors for compliance to a chosen class in MIL-D-28000, reference [3], and user-defined requirements.

2. Test Case Abstracts

Each abstract contains the following information:

- version number;
- date;
- compliance criteria;
- versions of documents to which the test case was developed;
- deviations.

The Table of Contents depicts an index of all test cases presently available. The abstracts can be found in Section 2, Test Case Abstracts.
2.1. PYRAMID

Version:  B

Date:   March 19, 1993

Concept or Application Scenario (circle one)  CONCEPTS

Criteria:  Complies with Classes II and IV
  View/Drawing/Model relationships
  Layering
  Visualization techniques

Revisions and release dates of documents to which this test case was developed:

  MIL-D-28000:    Revision:  A, Amendment 1
                  Date:   14 December 1992

Test Case Development and
Verification Guide for
MIL-D-28000, Version 1.0, March 19, 1993, CTN Report 93-017

Deviations:
IGES file conforms to the above specification with an exception to the requirement on the existence of MIL-STD-1840-compliant IGES data file header records.  PC-based software to generate these records and to append them onto the IGES file was not available at the time this test case was developed.

The drawing format in this test case does not comply with MIL-STD-100C.
2.2. SPINDL

Version: A

Date: March 19, 1993

Concept or Application Scenario (circle one) APPLICATION SCENARIO

Criteria: Complies with Classes II and IV
Piece part manufacture application scenario
The following features are emphasized:
- taper
- threads
- slot
- drill hole
- counterbore
- blind hole
  and the following annotation:
- dimensions
- tolerances
- feature control symbols

Revisions and release dates of documents to which this test case was developed:

MIL-D-28000: Revision: A, Amendment 1
Date: 14 December 1992

Test Case Development and Verification Guide for

Deviations:
Visual presentation of data base depends upon surface meshing which is not conveyed by this test case.
APPENDIX: REFERENCES


Copies of references [1] and [2] are available from the CALS Test Network Office which may be contacted at (513) 257-3085 or lammers@logdisl.hq.aflc.af.mil.